

## Dual N-Channel MOSFET

### DESCRIPTION

SMC4802 is the Dual N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance. This device is ideal for load switch applications.

### PART NUMBER INFORMATION

**SMC 4802 M - TR G**  
 a      b      c      d      e

- a : Company name.
- b : Product Serial number.
- c : Package code            M:SOP-8
- d : Handling code            TR:Tape&Reel
- e : Green produce code    G:RoHS Compliant

### FEATURES

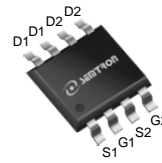
**$V_{DS} = 30V, I_D = 11.5A$**

$R_{DS(ON)} = 7m\Omega (Typ.) @ V_{GS} = 10V$   
 $R_{DS(ON)} = 8m\Omega (Typ.) @ V_{GS} = 4.5V$

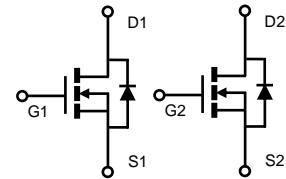
- ◆ High power and current handling capability

### APPLICATIONS

- ◆ DC-DC Power System
- ◆ Portable Equipment
- ◆ Power Management



SOP-8



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_A = 25^\circ C$	11.5
		$T_A = 70^\circ C$	9.2
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	46	A
$I_{AS}$	Avalanche Current <sup>A</sup>	15	A
$E_{AS}$	Single Pulse Avalanche energy $L=0.3mH$ <sup>AF</sup>	38	mJ
$P_D$	Power Dissipation <sup>B</sup>	$T_A = 25^\circ C$	1.9
		$T_A = 70^\circ C$	1.2
$T_J$	Operation Junction Temperature	-55/150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55/150	$^\circ C$

### THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>		65	$^\circ C/W$
	Thermal Resistance Junction to Ambient <sup>BD</sup>			
$R_{\theta JC}$	Thermal Resistance Junction to Case		38	

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

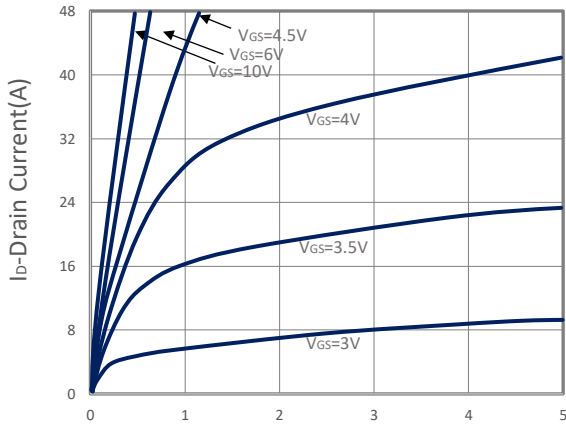
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1	1.7	2.5	V
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$			$\pm 100$	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V, T_J=25^\circ\text{C}$			1	$\mu A$
		$V_{DS}=24V, V_{GS}=0V, T_J=75^\circ\text{C}$			10	
$R_{DS(ON)}$	Drain-source On-Resistance <sup>E</sup>	$V_{GS}=10V, I_D=11.5A$		7	8.5	m $\Omega$
		$V_{GS}=4.5V, I_D=10A$		8	11	
$G_{fs}$	Forward Transconductance	$V_{DS}=10V, I_D=10A$		28		S
<b>Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage <sup>E</sup>	$I_S=1A, V_{GS}=0V$		0.7	1	V
$I_S$	Continuous Source Current				5.8	A
$t_{rr}$	Reverse Recovery Time	$I_S=10A, di/dt=100A/\mu s$		22		ns
$Q_{rr}$	Reverse Recovery Charge			14		nC
<b>Dynamic and Switching Parameters</b>						
$Q_g$	Total Gate Charge (10V)	$V_{DS}=15V, V_{GS}=10V, I_D=10A$		24.7	33.4	nC
$Q_g$	Total Gate Charge (4.5V)			12	16.8	
$Q_{gs}$	Gate-Source Charge			2.5	3.5	
$Q_{gd}$	Gate-Drain Charge			7.4	10.4	
$C_{iss}$	Input Capacitance	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$		1210	1694	pF
$C_{oss}$	Output Capacitance			220	308	
$C_{rss}$	Reverse Transfer Capacitance			198	277	
$R_g$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$		2	3	
$t_{d(on)}$	Turn-On Time	$V_{DD}=15V, V_{GEN}=10V, R_G=3\Omega, I_D=1A$		8.5	16	nS
$t_r$				16.2	31	
$t_{d(off)}$	Turn-Off Time			30	57	
$t_f$				10.2	19	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

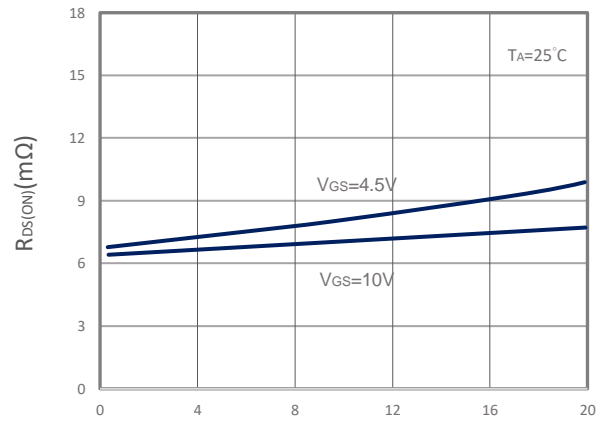
- A. Pulsed width limited by maximum junction temperature,  $T_{J(MAX)}=150^\circ\text{C}$ .
- B. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature  $T_{J(MAX)}=150^\circ\text{C}$  (initial temperature  $T_A=25^\circ\text{C}$ ).
- C.  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-ambient thermal resistance,  $t \leq 10\text{sec}$ .
- D.  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance ( $R_{\theta JC}$ ) is more useful in additional heat sinking is used.
- E. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
- F. The EAS data shows Max, tested and pulse width limited by  $T_{J(MAX)}=150^\circ\text{C}$  (initial temperature  $T_J=25^\circ\text{C}$ ).

The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date. We assume no responsibility for any infringement of patents, patent rights, or other rights arising from the use of any information and circuitry in this datasheet.

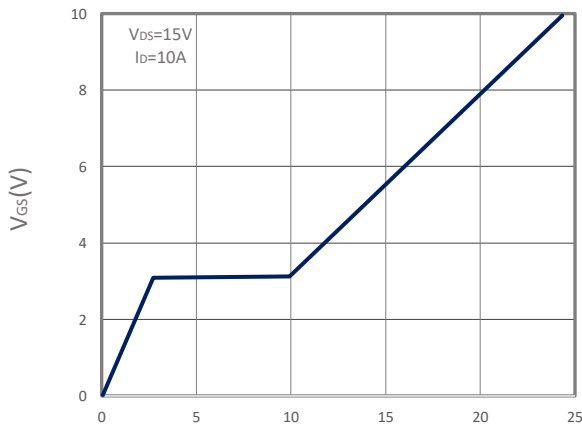
## TYPICAL CHARACTERISTICS



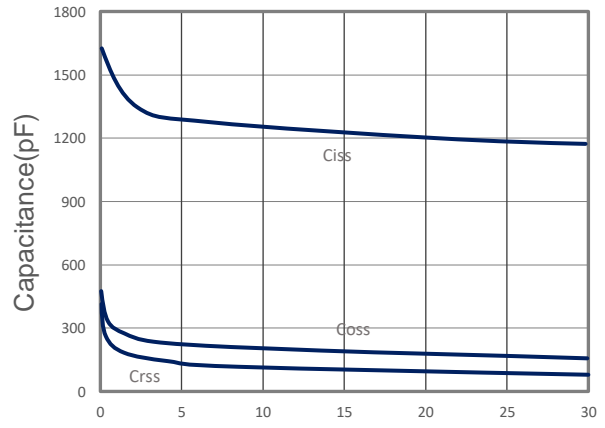
V<sub>DS</sub>-Drain Source Voltage(V)  
**Output Characteristics**



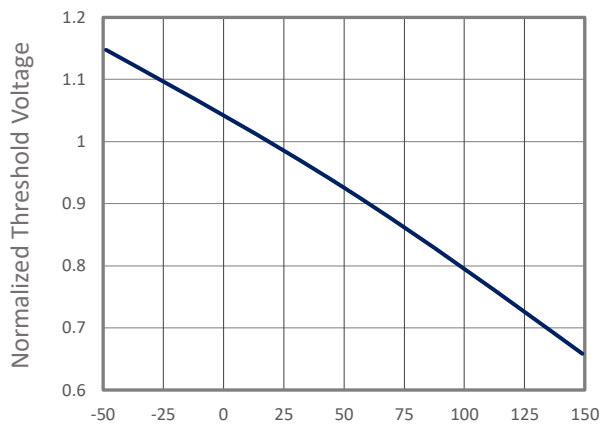
Id-Drain Current(A)  
**Drain-Source On Resistance**



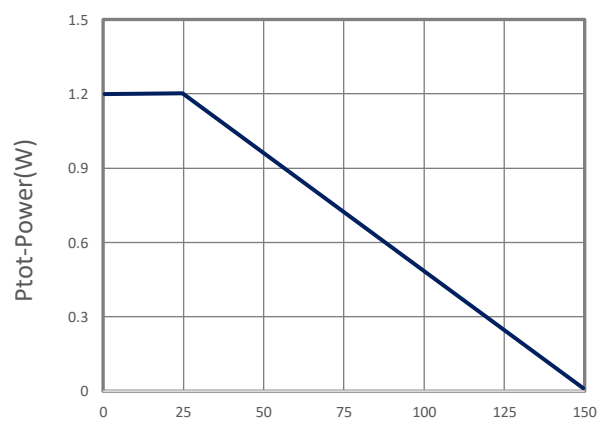
Q<sub>g</sub>-Gate Charge(nC)  
**Gate Charge**



V<sub>DS</sub>-Drain Source Voltage(V)  
**Capacitance**

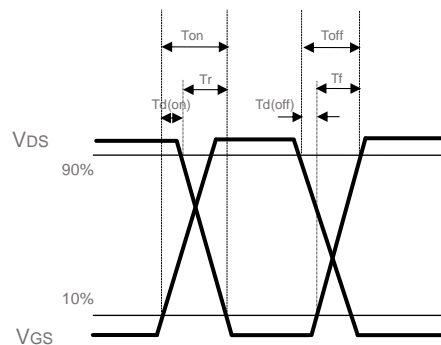
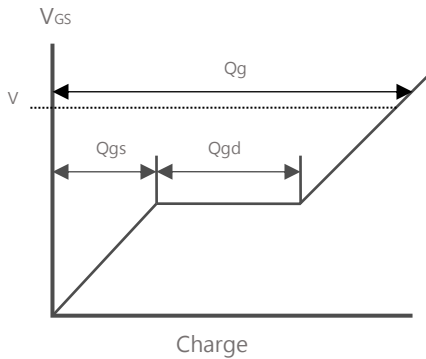
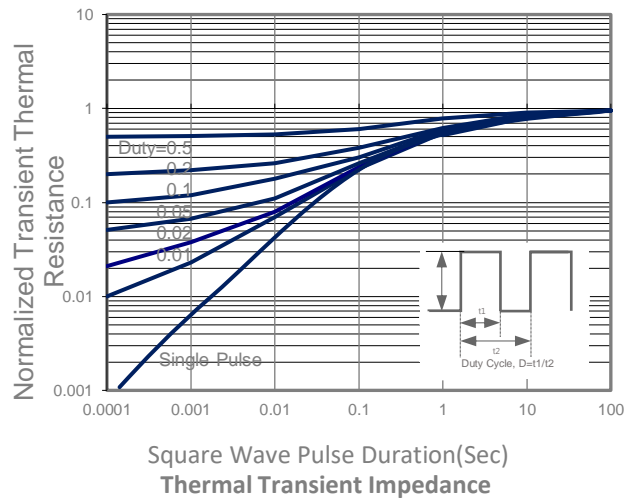
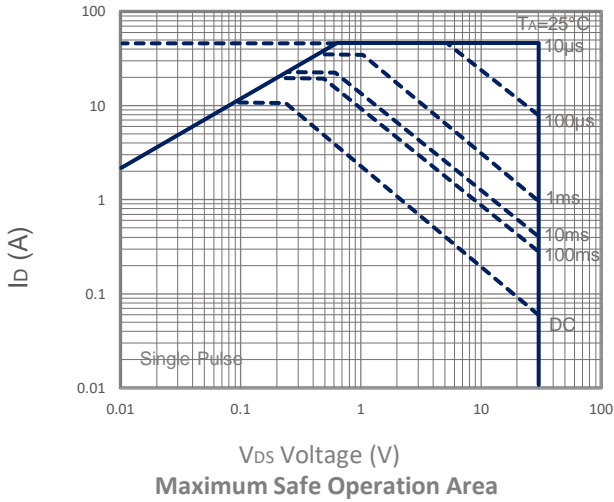
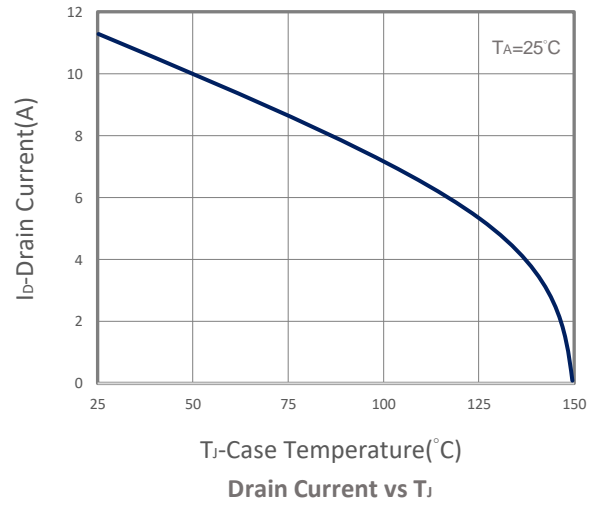
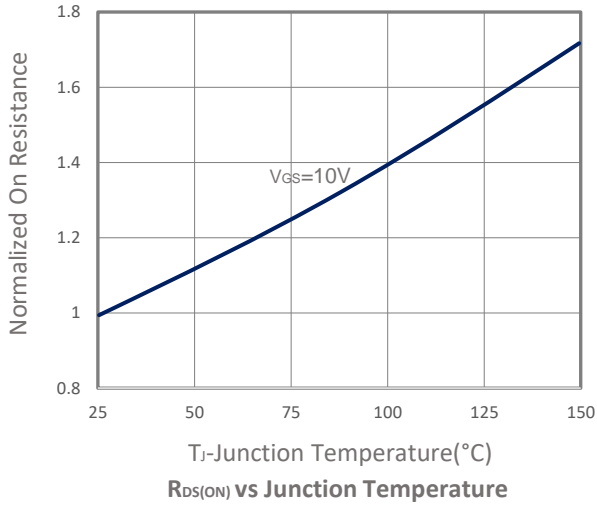


T<sub>J</sub>-Junction Temperature(°C)  
**Gate Threshold Voltage**

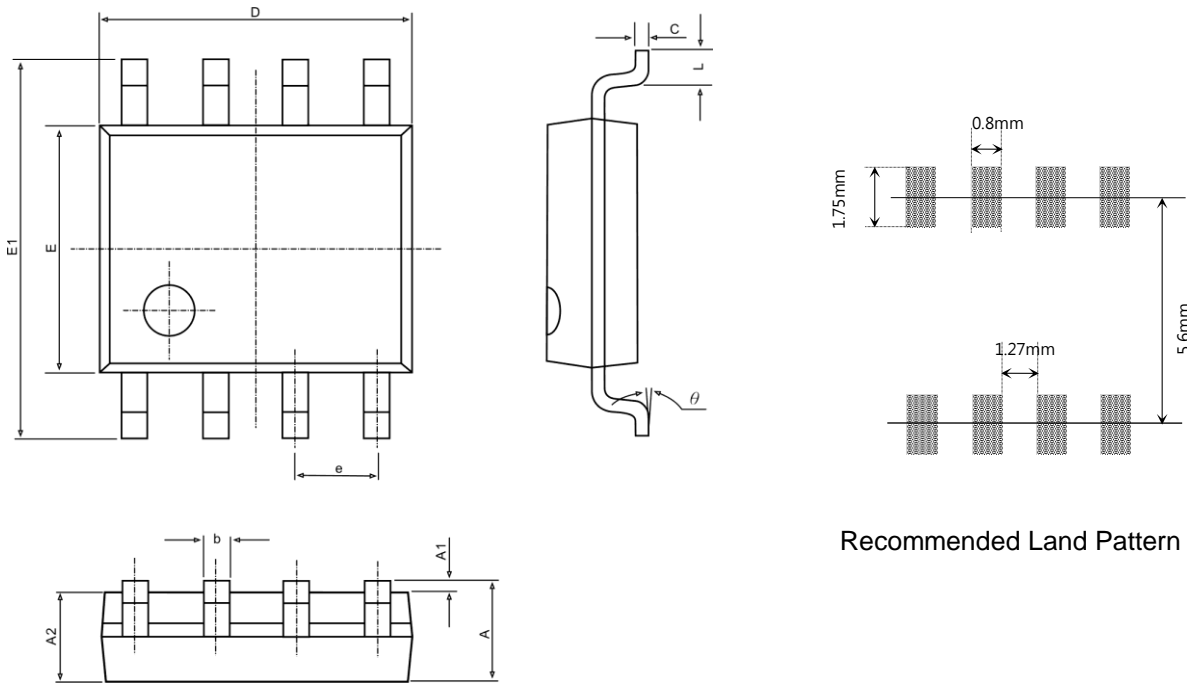


T<sub>J</sub>-Junction Temperature(°C)  
**Power Dissipation**

## TYPICAL CHARACTERISTICS



## ■ SOP-8 PACKAGE DIMENSIONS



Recommended Land Pattern

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.130	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270BSC.		0.050BSC.	
L	0.400	1.270	0.016	0.005
θ	0°	8°	0°	8°